

Pulsed EM field response of a thin, high-contrast, finely layered structure with dielectric and conductive properties

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Synopsis:

- Motivation
- Formulation of the problem
- The thin-layer, high-contrast boundary condition
- Plane-wave reflection against and transmission across a thin, high-contrast layer of infinite extent
- Numerical results for an incident wave of rectangular pulse shape (E -polarization)
- Numerical results for an incident wave of rectangular pulse shape (H -polarization)

Examples of thin, high-contrast, finely layered structures in Electronics and Telecommunication Engineering:

- Aircraft radar radomes
- Integrated optical devices
- Micro- and Nano-Electronic devices

Difficulties with computational discretization of the Maxwell EM field equations:

⇒ **FINENESS OF THE GRIDDING/MESHING**

'Global' type conditions:

- Harrington & Mautz (1975) \implies based on contrast volume source EM field representations and associated Green's functions
- Koh & Sarabandi (2005) \implies based on Lorentz's reciprocity theorem and Rumsey's EM field reaction concept

'Local' type conditions:

- Collin (1960), Senior (1981) \implies based on EM field integration across the layer

'Moving average' type conditions (acoustics and elastodynamics):

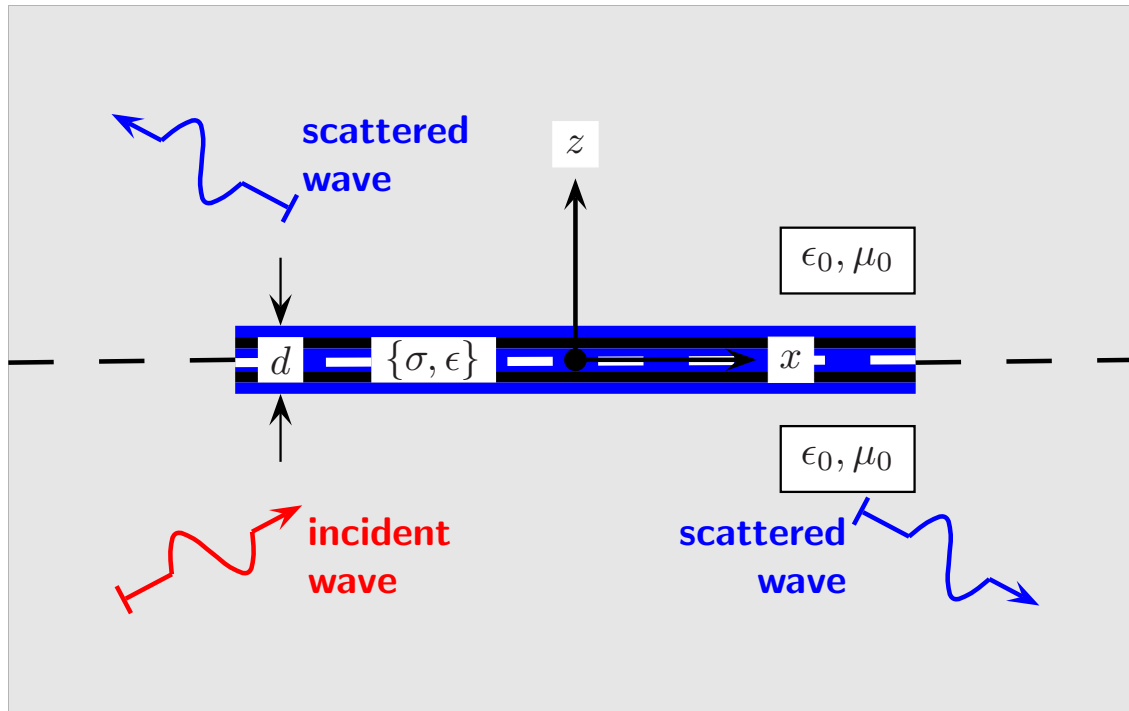
- Schoenberg & Muir (1989), Hovem (1995) \implies based on moving averages perpendicular to the layering

All of these: \implies FREQUENCY-DOMAIN CONDITIONS

Present (time-domain) approach \implies based on:

- Volume-integrated time-domain Maxwell field equations
- Contrast-source scattering description
- Local field continuity considerations across the layer
- Lumped-element capacitance and conductance description of the contrast sheet electric current density
- Time-domain circulation and flux integral form of Maxwell field equations + compatibility relations
- 'Edge condition' on contrast sheet electric current density
- Time-domain uniqueness considerations via time Laplace transform methods [De Hoop (2003)]

Thin, high-contrast layer ($\mathcal{D} = \{(x, y) \in \mathbb{R}^2, -d/2 < z < d/2\}$):



Layer conductance:

- $$G_L = \int_{z=-d/2}^{d/2} \sigma(z) dz = O(1) \text{ as } d \downarrow 0$$

Layer capacitance:

- $$C_L = \int_{z=-d/2}^{d/2} \epsilon(z) dz = O(1) \text{ as } d \downarrow 0$$

Cartesian coordinate position vector: • $\mathbf{r} = x\mathbf{i}_x + y\mathbf{i}_y + z\mathbf{i}_z \in \mathbb{R}^3$

Time coordinate: • $t \in \mathbb{R}$

Volume-integrated Maxwell field equations in sourcefree domain Ω with boundary surface $\partial\Omega$:

- $$\int_{\partial\Omega} \boldsymbol{\nu} \times \mathbf{H} dA = \int_{\Omega} (\epsilon \partial_t \mathbf{E} + \sigma \mathbf{E}) dV$$
- $$\int_{\partial\Omega} \boldsymbol{\nu} \times \mathbf{E} dA = - \int_{\Omega} \mu_0 \partial_t \mathbf{H} dV$$

Ω = 'pillbox' perpendicularly crossing the layer \implies interface boundary conditions:

- $$\mathbf{i}_z \times \mathbf{E}(x, y, d/2, t) - \mathbf{i}_z \times \mathbf{E}(x, y, -d/2, t) = O(d)$$

for $(x, y) \in \Sigma$ as $d \downarrow 0$
- $$\mathbf{i}_z \times \mathbf{H}(x, y, d/2, t) - \mathbf{i}_z \times \mathbf{H}(x, y, -d/2, t) = (G_L + C_L \partial_t) \mathbf{E}(x, y, 0, t) + O(d)$$

for $(x, y) \in \Sigma$ as $d \downarrow 0$

Scattering description:

- $\mathbf{E}^s(\mathbf{r}, t) = \mathbf{E}(\mathbf{r}, t) - \mathbf{E}^i(\mathbf{r}, t)$ • $\mathbf{H}^s(\mathbf{r}, t) = \mathbf{H}(\mathbf{r}, t) - \mathbf{H}^i(\mathbf{r}, t)$ for $\mathbf{r} \in \mathbb{R}^3$

Volume-integrated Maxwell field equations ($\mathcal{D} \subset \Omega$):

- $\int_{\partial\Omega} \boldsymbol{\nu}^{\text{out}} \times \mathbf{H}^s dA = \int_{\Omega} \epsilon_0 \partial_t \mathbf{E}^s + \int_{\mathcal{D}} \mathbf{J}^s dV$
- $\int_{\partial\Omega} \boldsymbol{\nu}^{\text{out}} \times \mathbf{E}^s dA = - \int_{\Omega} \mu_0 \partial_t \mathbf{H}^s dV$

Volume source density of electric contrast current:

- $\mathbf{J}^s = (\epsilon - \epsilon_0) \partial_t \mathbf{E} + \sigma \mathbf{E}$ with $\text{supp}(\mathbf{J}^s) = \mathcal{D}$

Contrast sheet electric current density:

- $\mathbf{J}_{\text{sheet}}^s = (G_L + C_L \partial_t) \mathbf{E}(x, y, 0, t)$ for $(x, y) \in \Sigma$

Local interface boundary conditions (scattering description):

- $\mathbf{i}_z \times \mathbf{E}^s(x, y, d/2, t) - \mathbf{i}_z \times \mathbf{E}^s(x, y, -d/2, t) = O(d)$
for $(x, y) \in \Sigma$ as $d \downarrow 0$
- $\mathbf{i}_z \times \mathbf{H}^s(x, y, d/2, t) - \mathbf{i}_z \times \mathbf{H}^s(x, y, -d/2, t) = \mathbf{J}_{\text{sheet}}^s + O(d)$
for $(x, y) \in \Sigma$ as $d \downarrow 0$

Evidently: $\mathbf{i}_z \cdot \mathbf{J}_{\text{sheet}}^s = 0 \implies$

Scattered field \subset Class of 'even' EM fields w.r.t. $\{z = 0\}$:

- $\{E_x^s, E_y^s, H_z^s\}(x, y, -z, t) = \{E_x^s, E_y^s, H_z^s\}(x, y, z, t)$ for all $\mathbf{r} \in \mathbb{R}^3$
- $\{E_z^s, H_x^s, H_y^s\}(x, y, -z, t) = -\{E_z^s, H_x^s, H_y^s\}(x, y, z, t)$ for all $\mathbf{r} \in \mathbb{R}^3$

\implies **REDUCTION IN COMPUTATION TIME**

Circulation/Flux integral form of Maxwell's field equations

(\mathcal{S} = bounded two-sided surface, \mathcal{C} = oriented boundary curve of \mathcal{S}):

- $\oint_{\mathcal{C}} \mathbf{H}^s \cdot \boldsymbol{\tau} ds = \int_{\mathcal{S}} (\epsilon_0 \partial_t \mathbf{E}^s + \mathbf{J}^s) \cdot \boldsymbol{\nu} dA$
- $\oint_{\mathcal{C}} \mathbf{E}^s \cdot \boldsymbol{\tau} ds = - \int_{\mathcal{S}} \mu_0 \partial_t \mathbf{H}^s \cdot \boldsymbol{\nu} dA$

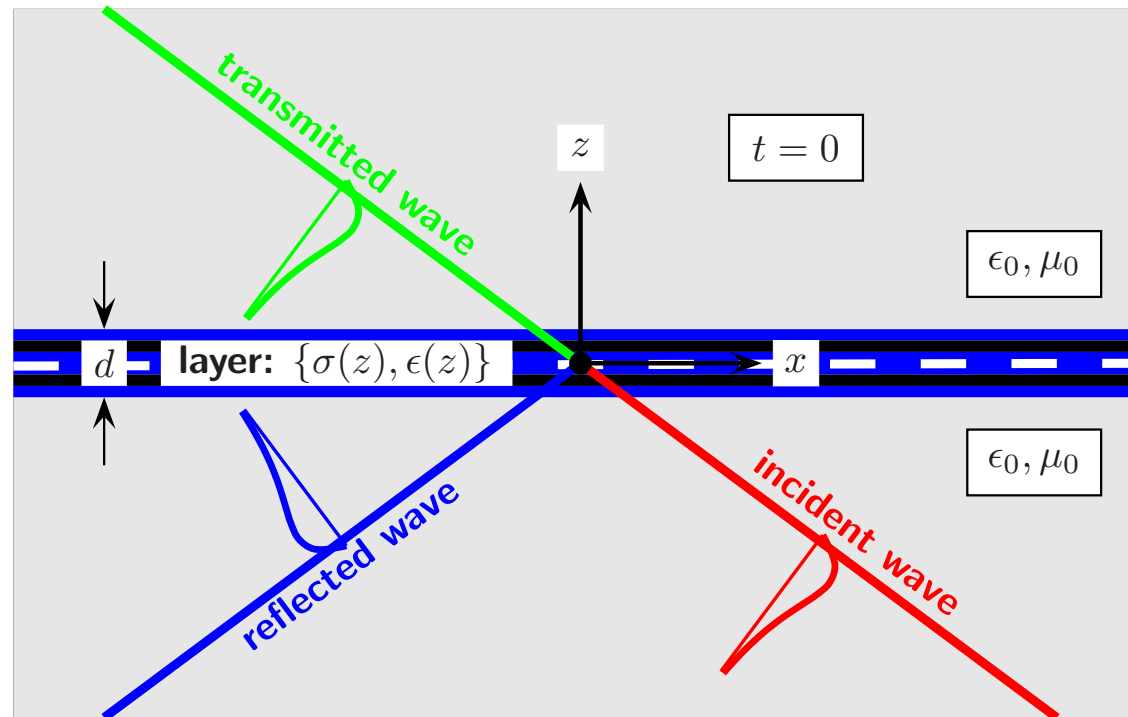
EM field compatibility relations:

- $\int_{\text{closed surface}} (\epsilon_0 \partial_t \mathbf{E}^s + \mathbf{J}^s) \cdot \boldsymbol{\nu}^{\text{out}} dA = 0$
- $\int_{\text{closed surface}} \mu_0 \partial_t \mathbf{H}^s \cdot \boldsymbol{\nu}^{\text{out}} dA = 0$

\Rightarrow 'Edge condition' on $\mathbf{J}_{\text{sheet}}^s$:

- $\boldsymbol{\nu}_{\Sigma} \cdot \mathbf{J}_{\text{sheet}}^s = 0$ for $(x, y) \in \partial\Sigma$

Thin, high-contrast layer of infinite extent



- $\mathcal{D}^- = \{(x, y) \in \mathbb{R}^2, -\infty < z < 0\}$ (**incident + reflected wave**)
- $\mathcal{D}^+ = \{(x, y) \in \mathbb{R}^2, 0 < z < \infty\}$ (**transmitted wave**)

Plane pulsed E -polarized field ($\alpha_x^2 + \alpha_z^2 = 1$)

Incident field:

- $\{H_x^i, E_y^i, H_z^i\} = \{-\alpha_z Y_0, 1, \alpha_x Y_0\} \times E_0^i [t - (\alpha_x x + \alpha_z z)/c_0]$ for $\mathbf{r} \in \mathbb{R}^3$

Scattered field:

- $\{H_x^s, E_y^s, H_z^s\} = \{\mp \alpha_z Y_0, 1, \alpha_x Y_0\} E_0^s [t - (\alpha_x x \pm \alpha_z z)/c_0]$ for $\mathbf{r} \in \mathcal{D}^\pm$

Medium parameters:

- $c_0 = (\epsilon_0 \mu_0)^{-1/2} =$ electromagnetic wave speed in background medium
- $Y_0 = (\epsilon_0 / \mu_0)^{1/2} =$ plane-wave admittance of background medium

Time-domain scattering coefficient:

- $E_0^s(t) = S^E(t) \overset{(t)}{*} E_0^i(t)$ • $\overset{(t)}{*} =$ time convolution

Plane pulsed H -polarized field ($\alpha_x^2 + \alpha_z^2 = 1$)

Incident field:

- $\{E_x^i, H_y^i, E_z^i\} = \{\alpha_z Z_0, 1, -\alpha_x Z_0\} H_0^i [t - (\alpha_x x + \alpha_z z)/c_0]$ for $\mathbf{r} \in \mathbb{R}^3$

Scattered field:

- $\{E_x^s, H_y^s, E_z^s\} = \pm \{\pm \alpha_z Z_0, 1, -\alpha_x Z_0\} H_0^s [t - (\alpha_x x \pm \alpha_z z)/c_0]$ for $\mathbf{r} \in \mathcal{D}^\pm$

Medium parameters:

- $c_0 = (\epsilon_0 \mu_0)^{-1/2} =$ electromagnetic wave speed in background medium
- $Z_0 = (\mu_0 / \epsilon_0)^{1/2} =$ plane-wave impedance of background medium

Time-domain scattering coefficient:

- $H_0^s(t) = S^H(t) \underset{*}{\overset{(t)}{H_0^i(t)}}$ • $\underset{*}{\overset{(t)}{}} =$ time convolution

Via time Laplace transformation:

- $\{\hat{E}_0^i, \hat{H}_0^i\}(s) = \int_{t=0}^{\infty} \exp(-st) \{E_0^i, H_0^i\}(t) dt$ for $s \in \mathbb{C}$, $\text{Re}(s) > 0$

s -domain scattering coefficients:

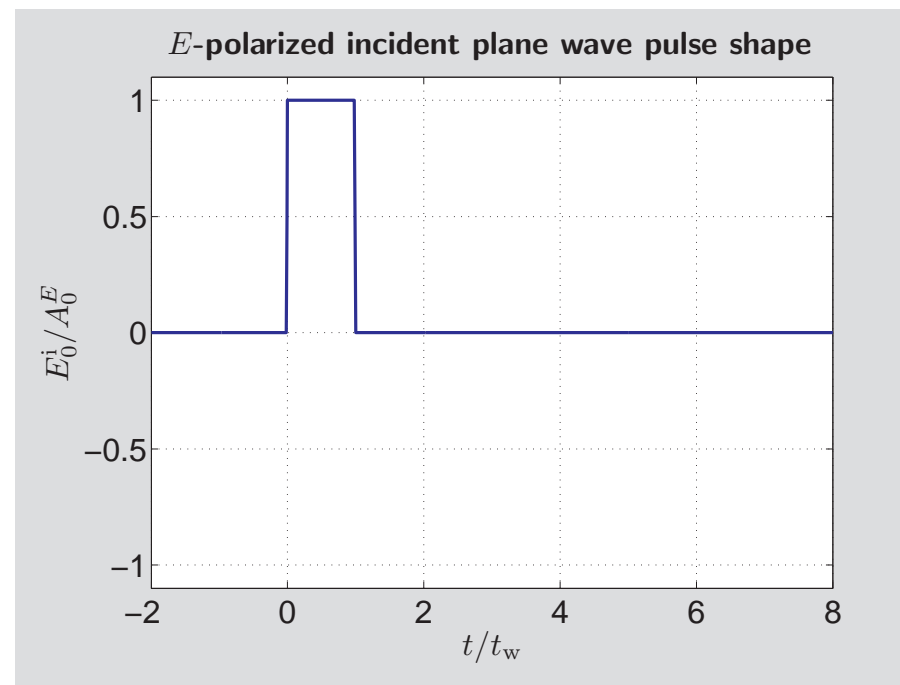
- $\hat{S}^E(s) = -1 + \frac{2\alpha_z Y_0}{2\alpha_z Y_0 + G_L + sC_L}$ • $\hat{S}^H(s) = -1 + \frac{2}{2 + \alpha_z Z_0(G_L + sC_L)}$

Time-domain scattering coefficients

($\delta(t)$ = Dirac delta distribution, $H(t)$ = Heaviside unit step function):

- $S^E(t) = -\delta(t) + T^E \exp(-\beta^E t) H(t)$
 - $T^E = 2\alpha_z Y_0 / C_L$ • $\beta^E = T^E + G_L / C_L$
- $S^H(t) = -\delta(t) + T^H \exp(-\beta^H t) H(t)$
 - $T^H = 2 / \alpha_z Z_0 C_L$ • $\beta^H = T^H + G_L / C_L$,

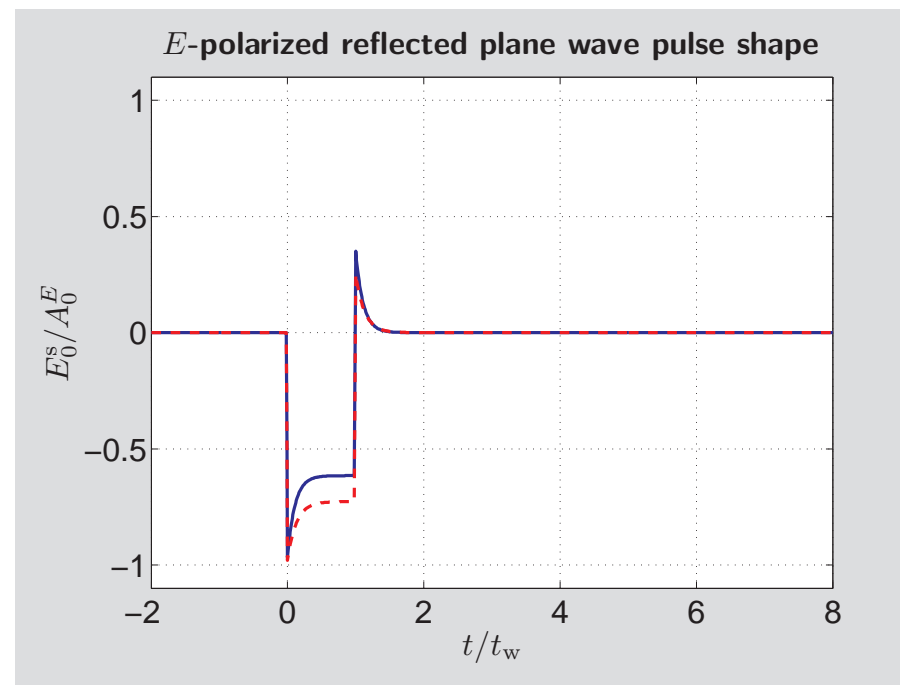
E-polarized incident pulse shape
 (A_0^E = amplitude, t_w = pulse time width):



Numerical results (1) (incident wave: rectangular pulse)

E-polarized reflected pulse shape

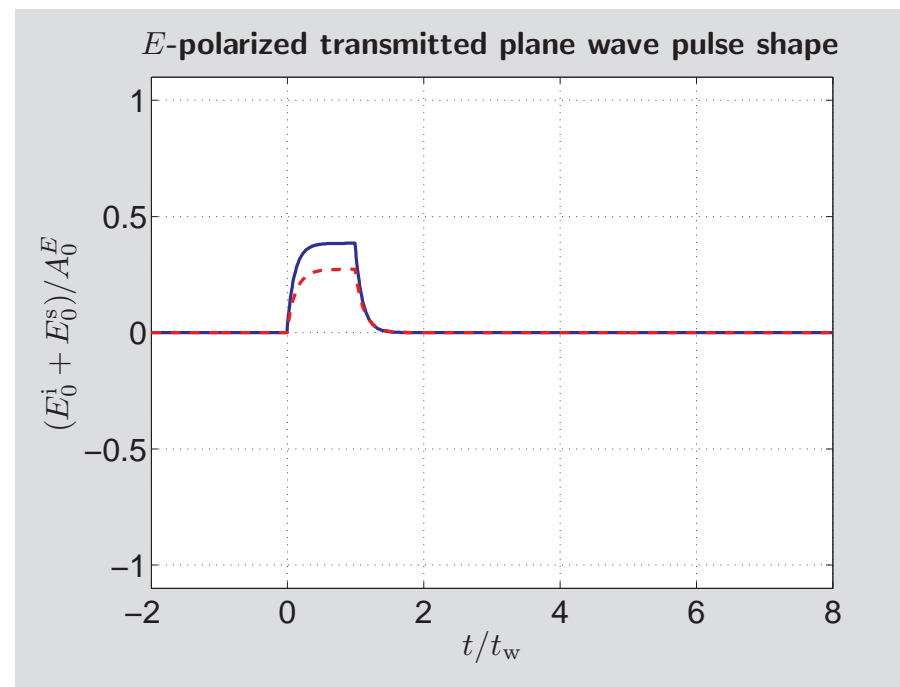
(A_0^E = amplitude, t_w = pulse time width incident wave):



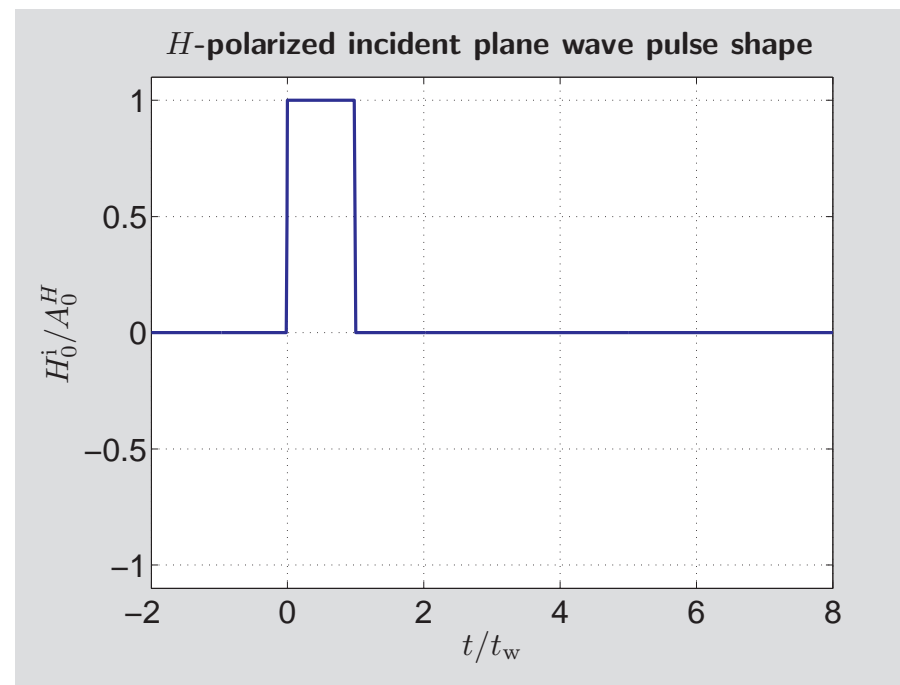
Numerical results (2) (incident wave: rectangular pulse)

E-polarized transmitted pulse shape

(A_0^E = amplitude, t_w = pulse time width incident wave):



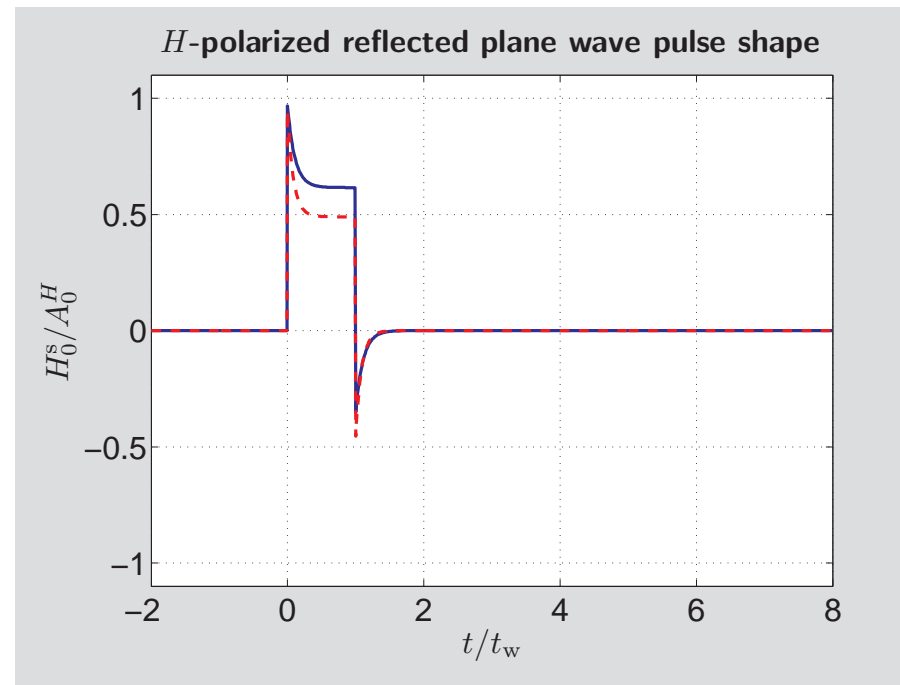
***H*-polarized incident pulse shape**
 (A_0^H = amplitude, t_w = pulse time width):



Numerical results (incident wave: rectangular pulse)

H-polarized reflected pulse shape

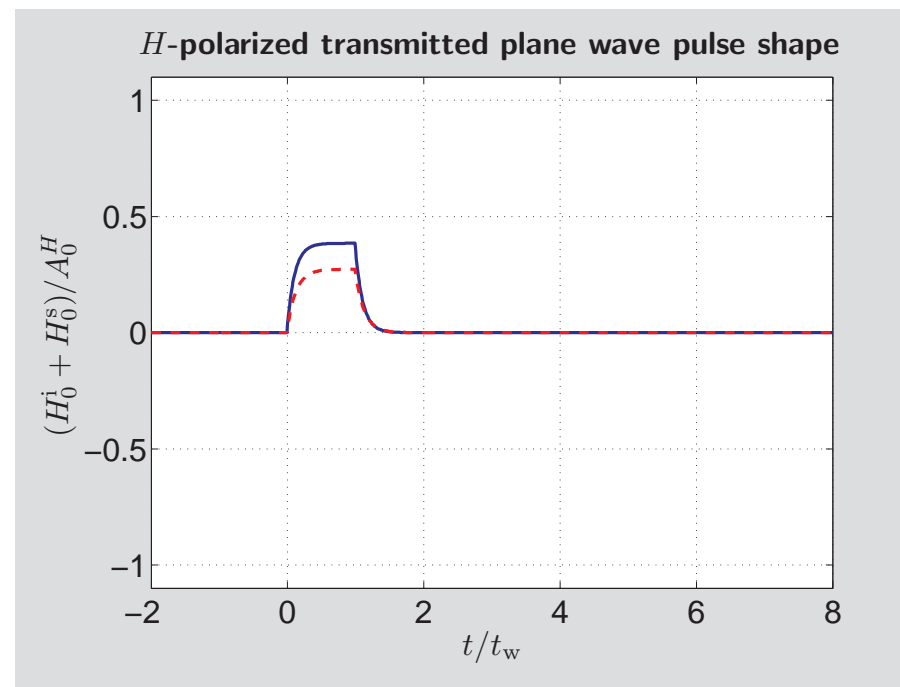
(A_0^H = amplitude, t_w = pulse time width incident wave):



Numerical results (incident wave: rectangular pulse)

H-polarized transmitted pulse shape

(A_0^H = amplitude, t_w = pulse time width incident wave):



Numerical results (6) (incident wave: rectangular pulse)